

Search Notes

Application/Control No.

10/562,890

Examiner

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Applicant(s)/Patent under
Reexamination

VAN DER VEEN ET AL.

Art Unit

2821

SEARCHED

Class	Subclass	Date	Examiner
315	254,257	1/8/2007	TC
315	274,224	1/8/2007	TC
315	205,307	1/8/2007	TC
315	146,201	1/8/2007	TC
315	171-172	1/8/2007	TC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
BRS	1/8/2007	TC